


<b>Search Notes</b>  	<b>Application/Control No.</b>  10582963	<b>Applicant(s)/Patent Under Reexamination</b>  IWAKUMA ET AL.
	<b>Examiner</b>  Vu Nguyen	<b>Art Unit</b>  1796

SEARCHED			
Class	Subclass	Date	Examiner
428	690, 917	1/20/2010	/V.N./
313	504, 506		
257	E51.047		
548	440		
546	101		
540	587		
556	407	1/20/2010	/V.N./

SEARCH NOTES		
Search Notes	Date	Examiner
Inventor search (eDAN, PALM, EAST)	1/8/2010	/V.N./
See STIC Search Results	1/12/2010	/V.N./
See EAST search report	1/21/2010	/V.N./
Google search	1/20/2010	/V.N./
Consulted with David Wu	1/20/2010	/V.N./
STIC Search	1/21/2010	/V.N./

INTERFERENCE SEARCH			
Class	Subclass	Date	Examiner
428	690	1/20/2010	/V.N./
	917		
313	504		
	506		
257	E51.047		
548	440		
546	101		
540	587		
556	407	1/20/2010	/V.N./

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